Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/823,324	Reexamination SIMPSON, FRAN	KLIN FULTON
Examiner	Art Unit	
Jason Mitchell	2193	Page 1 of 1

U.S. PATENT DOCUMENTS

				C.C. TATENT DOCUMENTO	
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,870,562 A	02-1999	Butman et al.	709/238
*	В	US-5,948,072 A	09-1999	Cink et al.	719/330
*	С	US-2001/0049717 A1	12-2001	Freeman et al.	709/203
*	D	US-2002/0133711 A1	09-2002	Peretti, Marco	713/193
*	Е	US-2003/0005090 A1	01-2003	Sullivan et al.	709/220
*	F	US-2004/0054569 A1	03-2004	Pombo et al.	705/007
*	G	US-6,874,020 B1	03-2005	Da Palma et al.	709/223
*	Н	US-7,069,321 B1	06-2006	Curtis et al.	709/225
*	Т	US-2006/0212146 A1	09-2006	Johnson et al.	700/089
*	J	US-7,278,158 B2	10-2007	Peretti, Marco	726/21
*	к	US-7,394,377 B2	07-2008	Banerjee, Ashok	340/572.1
*	L	US-7,433,917 B2	10-2008	Renaud, Benjamin Jean-Baptiste	709/203
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 841618 A2	05-1998	European Patent	CINK et al.	G06F 09/46
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

NON-PATENT DOCUMENTS		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	×	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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